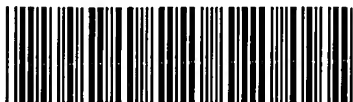


**Search Notes**

Application/Control No.

10/603,439

Examiner

J. Derek Rutten

Applicant(s)/Patent under  
Reexamination

SHAYLOR ET AL.

Art Unit

2192

**SEARCHED**

Class	Subclass	Date	Examiner
717	166	3/8/2007	JDR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See search notes			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	3/7/2007	JDR
717/162-167; 713/2; 719/332 text search only See search history printout	3/8/2007	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	3/8/2007	JDR
Tuan Dam (consulted re. allowable subj. matter)	3/8/2007	JDR
ACM - portal.acm.org IEEE - ieeexplore.ieee.org See search history printout	3/8/2007	JDR